

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10710698	CHEN ET AL.
	Examiner	Art Unit
	Kourtney R Salzman	4128

SEARCHED

Class	Subclass	Date	Examiner
204	192 and 192.12; 298, 298.16	11/29/2007	krs

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search in PALM	11/29/2007	krs
Assignee Search in PALM	11/29/2007	krs
Keyword Searching: axial\$3, magnet\$4, rotating, magnetron, method, backplate, degree, symmetr\$3, target in EAST	11/29/2007	krs
Assignee Search for Applied Materials, Inc. patents in EAST	11/29/2007	krs
Updated Searches in EAST	6/23/2008; 12/4/2008	krs
Search PAJ for magnetron sputtering and polarity	6/23/2008	krs

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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